

Search Notes

Application/Control No.

10/773,149

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

AIZAWA, MASAMI

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	203	8/1/2007	HN
↓	208		
↓	209		
↓	210		
370	466		
370	318		
455	13.4		
↓	21		
455	24		
375	147		
↓	148		
↓	316		
↓	324		
375	326	8/1/07	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	324	8/1/2007	HN
	316		
	147		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	8/1/2007	HN